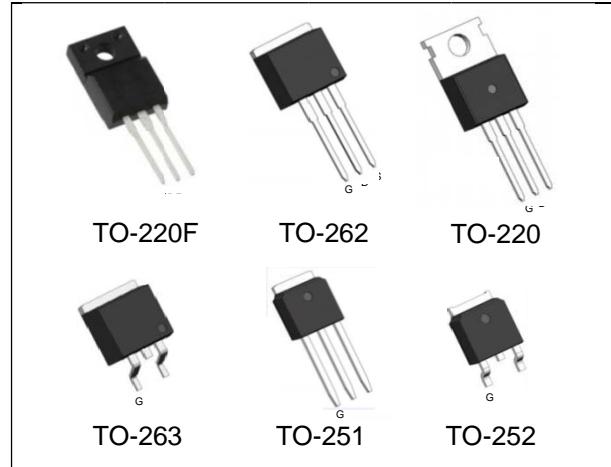


650V 0.35Ω Super Junction Power MOSFET

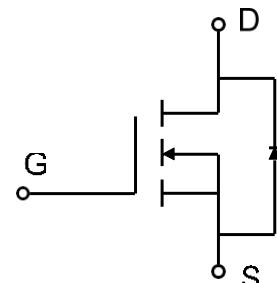
Description

WMOS™ EM is Wayon's 3rd generation super junction MOSFET family that is utilizing charge balance technology for extremely low on-resistance and low gate charge performance. WMOS™ EM is suitable for applications which require superior power density and outstanding efficiency.



Features

- $V_{DS} = 700V @ T_{j,max}$
- Typ. $R_{DS(on)} = 0.35\Omega$
- 100% UIS tested
- Pb-free plating, Halogen free



Applications

LED Lighting, Charger, Adapter, PC, LCD TV, Server

Absolute Maximum Ratings

Parameter	Symbol	WMK/WMM/WMO/WMP/WMN	WML	Unit
Drain-source voltage	V_{DSS}	650		V
Continuous drain current ¹⁾ $(T_c = 25^\circ C)$	I_D	11		A
$(T_c = 100^\circ C)$		6.5		A
Pulsed drain current ²⁾	I_{DM}	35		A
Gate-source voltage	V_{GS}	± 30		V
Avalanche energy, single pulse ³⁾	E_{AS}	145		mJ
Avalanche energy, repetitive ²⁾	E_{AR}	0.21		mJ
Avalanche current, repetitive ²⁾	I_{AR}	2		A
Power dissipation ($T_c = 25^\circ C$) - Derate above 25°C	P_D	85 0.68	31 0.25	W W/°C
Operating and storage temperature range	T_j, T_{stg}	-55 to +150		°C
Continuous diode forward current	I_S	11		A
Diode pulse current	$I_{S,pulse}$	35		A
MOSFET dv/dt ruggedness	dv/dt	50		V/ns
Peak diode recovery voltage slope	dv/dt	15		V/ns



WML13N65EM

Thermal Characteristics

Parameter	Symbol	WMK/WMM/WMO/WMP/WMN	WML	Unit
Thermal resistance, junction-to-case	$R_{\theta JC}$	1.47	4	°C/W
Thermal resistance, junction-to-ambient	$R_{\theta A}$	62	80	°C/W

Electrical Characteristics

$T_c = 25^\circ C$, unless otherwise noted							
Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit	
Static characteristics							
Drain-source breakdown voltage	BV_{DSS}	$V_{GS}=0 V, I_D=0.25 \text{ mA}$	650	-	-	V	
Gate threshold voltage	$V_{GS(\text{th})}$	$V_{DS}=V_{GS}, I_D=0.25 \text{ mA}$	2	3	4	V	
Drain cut-off current	I_{DSS}	$V_{DS}=650 V, V_{GS}=0 V,$ $T_j = 25^\circ C$ $T_j = 125^\circ C$	-	-	1	μA	
Gate leakage current, forward	I_{GSSF}	$V_{GS}=20 V, V_{DS}=0 V$	-	-	100	nA	
Gate leakage current, reverse	I_{GSSR}	$V_{GS}=-20 V, V_{DS}=0 V$	-	-	-100	nA	
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=10 V, I_D=2 A$	--	0.35	0.39	Ω	
Dynamic characteristics							
Input capacitance	C_{iss}	$V_{DS}=100 V, V_{GS}=0 V,$ $f = 1 \text{ MHz}$	-	710	-	pF	
Output capacitance	C_{oss}		-	25	-		
Reverse transfer capacitance	C_{rss}		-	2	-		
Turn-on delay time	$t_{d(on)}$	$V_{DD}=300 V, I_D=5 A$ $R_G=25 \Omega, V_{GS}=10 V$	-	20	-	ns	
Rise time	t_r		-	16	-		
Turn-off delay time	$t_{d(off)}$		-	61	-		
Fall time	t_f		-	17	-		
Gate charge characteristics							
Gate to source charge	Q_{gs}	$V_{DD}=480 V, I_D=5 A,$ $V_{GS} \text{ from } 0 \text{ to } 10 V$	-	3.4	-	nC	
Gate to drain charge	Q_{gd}		-	10.1	-		
Gate charge total	Q_g		-	20.3	-		
Gate plateau voltage	$V_{plateau}$		-	4.7	-		
Reverse diode characteristics							
Diode forward voltage	V_{SD}	$V_{GS}=0 V, I_F=2 A$	-	-	1.2	V	
Reverse recovery time	t_{rr}	$V_R=50 V, I_F=5 A,$ $dI_F/dt=100 A/\mu s$	-	213	-	ns	
Reverse recovery charge	Q_{rr}		-	2.1	-	μC	
Peak reverse recovery current	I_{rrm}		-	20	-	A	

Notes:

1. Limited by $T_{j\max}$. Maximum duty cycle D=0.5.
2. Repetitive rating: pulse width limited by maximum junction temperature.
3. $I_{AS}=2 A, V_{DD}=50 V, R_G=25 \Omega$, starting $T_j=25^\circ C$.

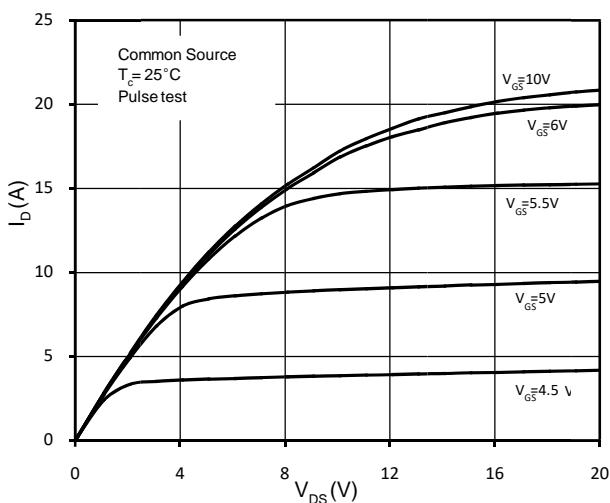


Figure 1. On-Region Characteristics

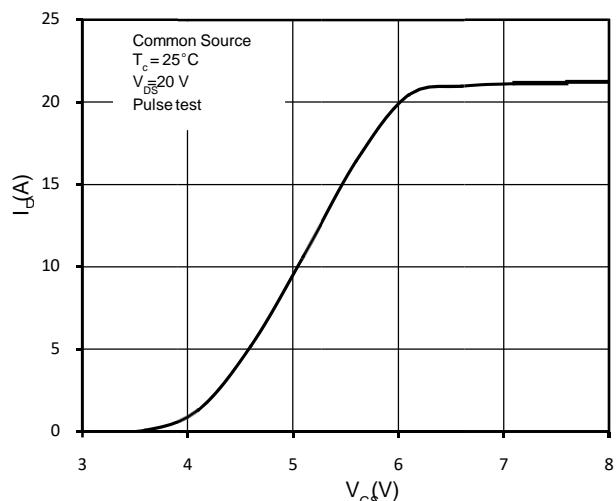


Figure 2. Transfer Characteristics

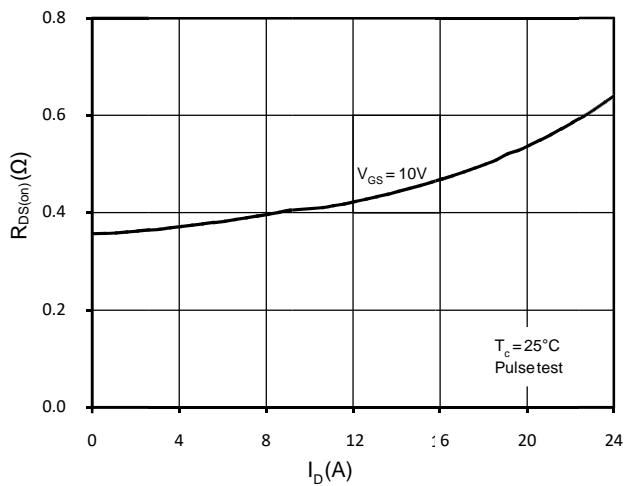


Figure 3. Static Drain-Source On Resistance

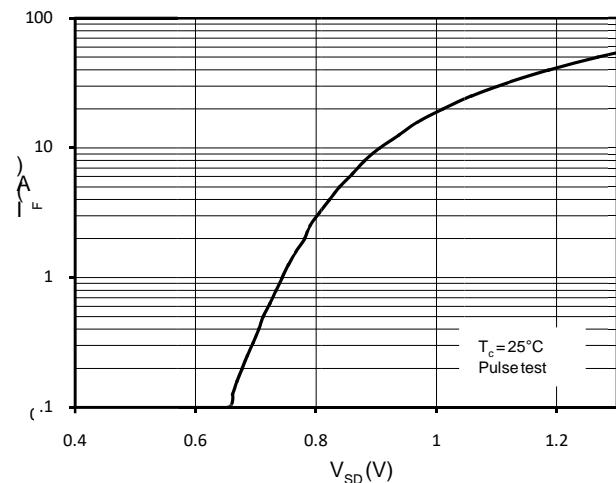


Figure 4. Body-Diode Forward Characteristics

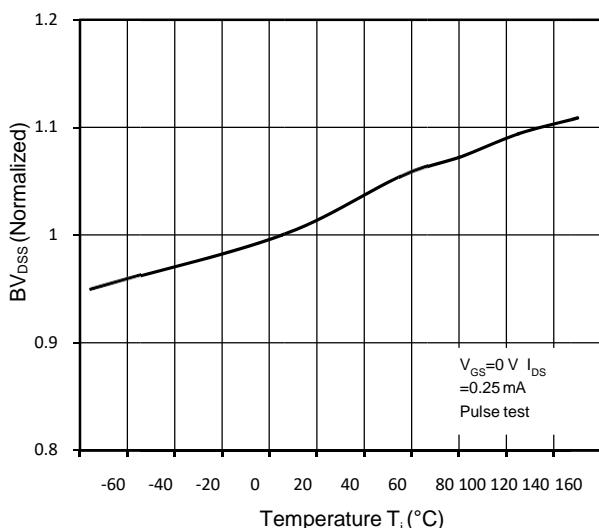


Figure 5. Normalized BV_{DSS} vs. Temperature

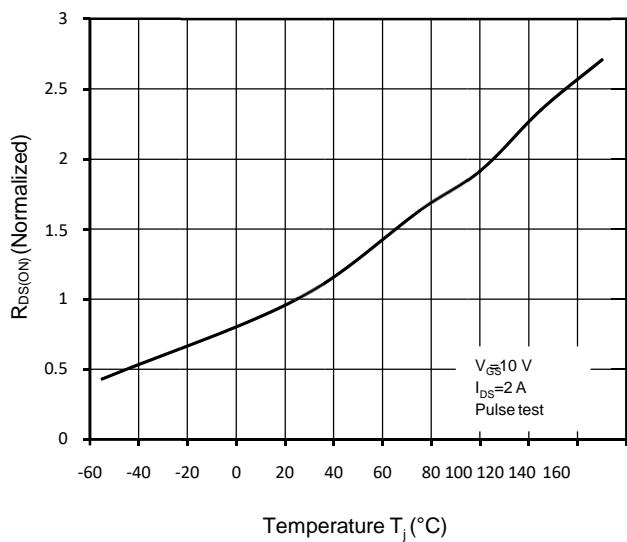


Figure 6. Normalized $R_{DS(on)}$ vs. Temperature

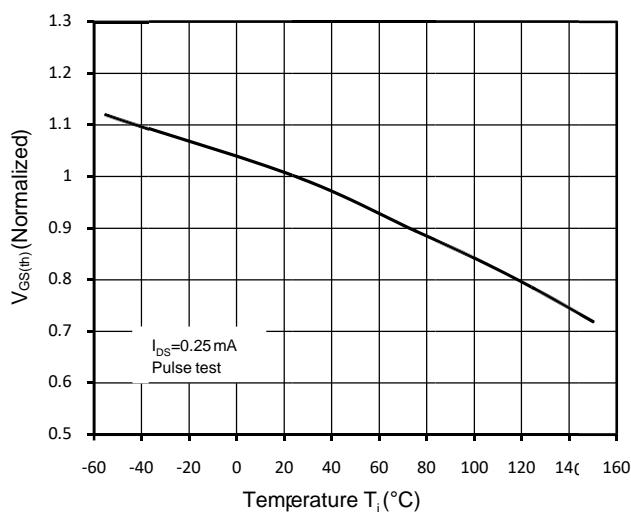


Figure 7. Threshold Voltage vs. Temperature

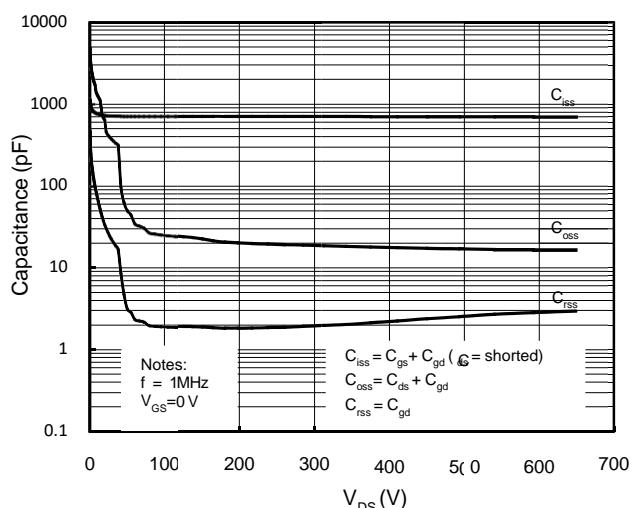


Figure 8. Capacitance Characteristics

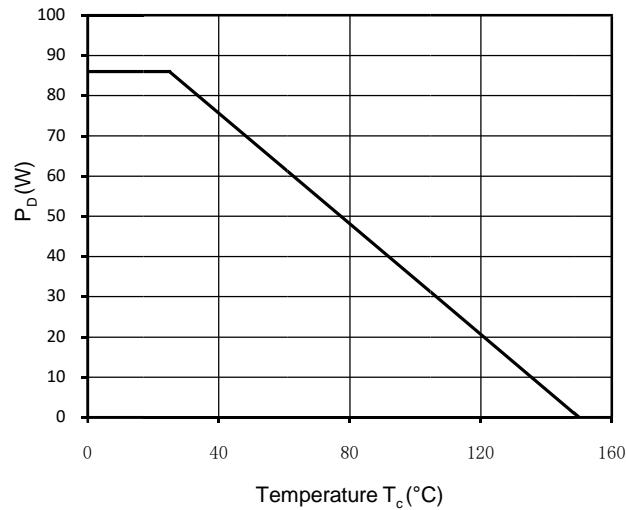


Figure 9. Power Dissipation

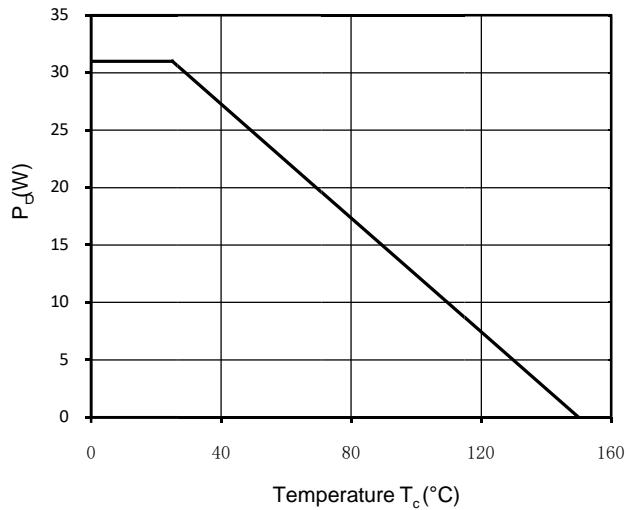


Figure 10. Power Dissipation (TO-220F)

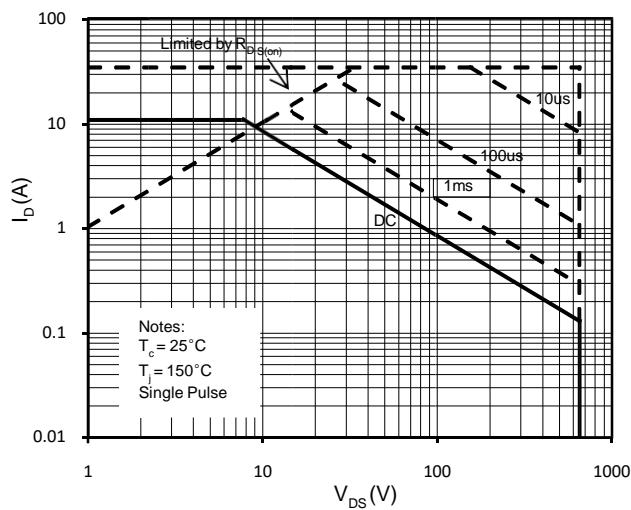


Figure 11. Maximum Safe Operating Area

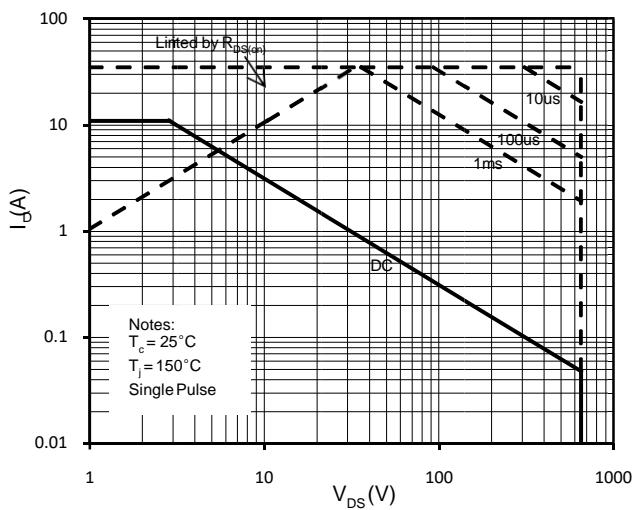


Figure 12. Maximum Safe Operating Area(TO-220F)

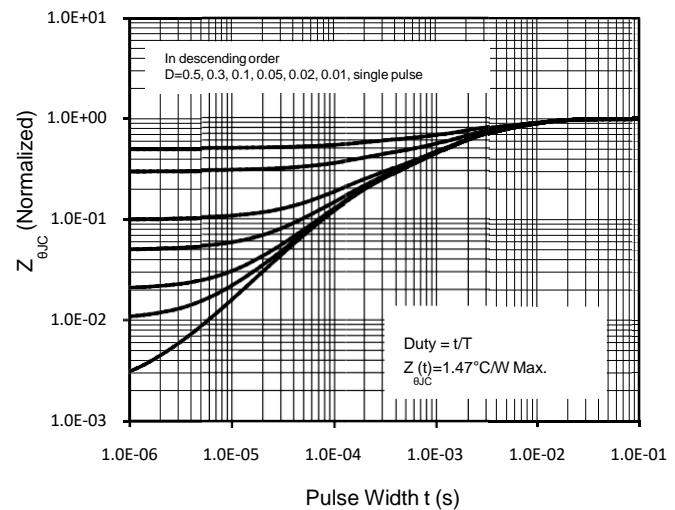
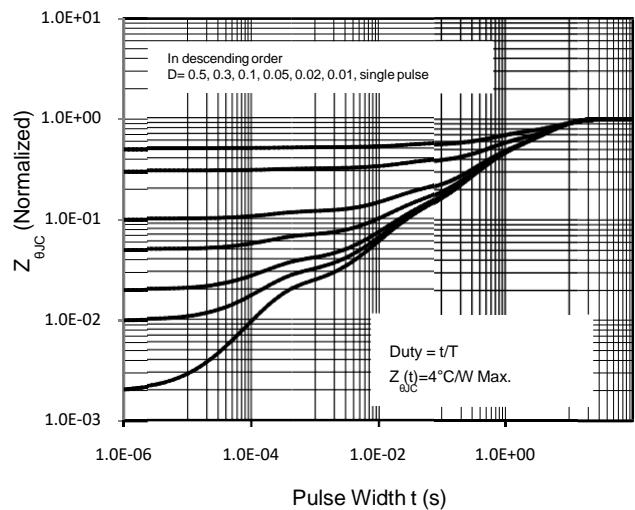


Figure 13. Transient Thermal Response Curve (TO-220F)

Figure 14. Transient Thermal Response Curve

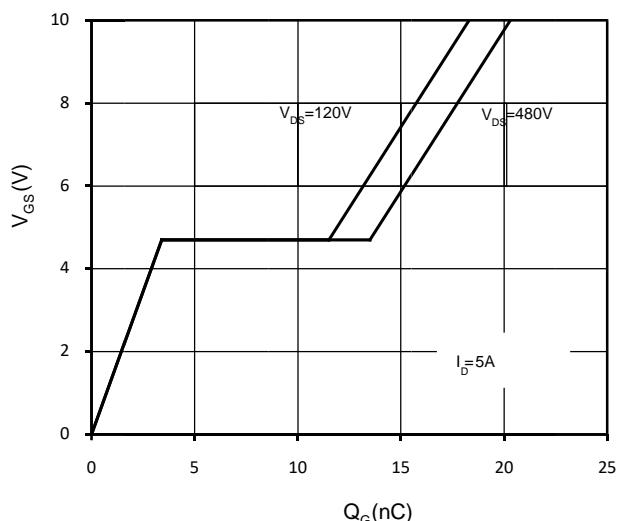
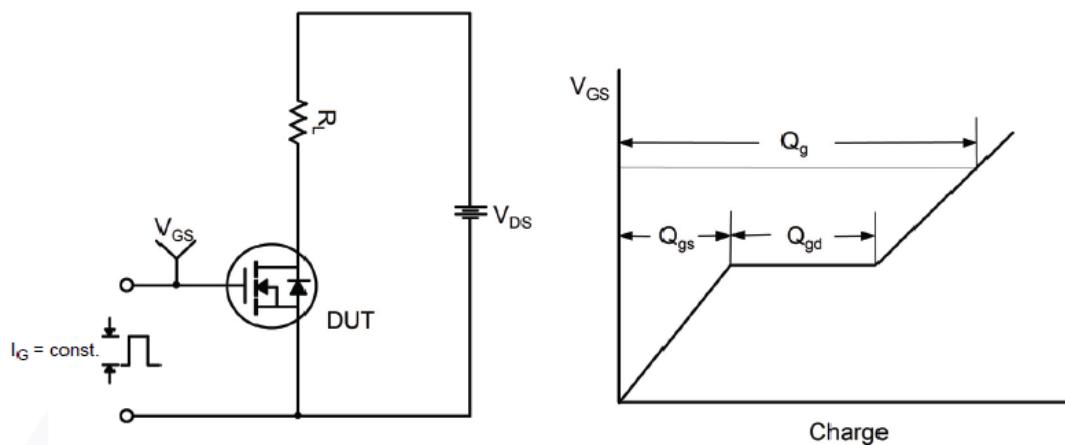
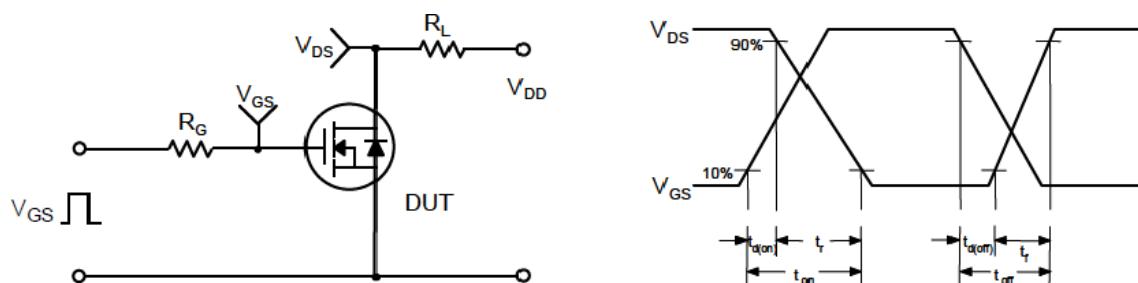


Figure 15. Gate Charge Characteristics

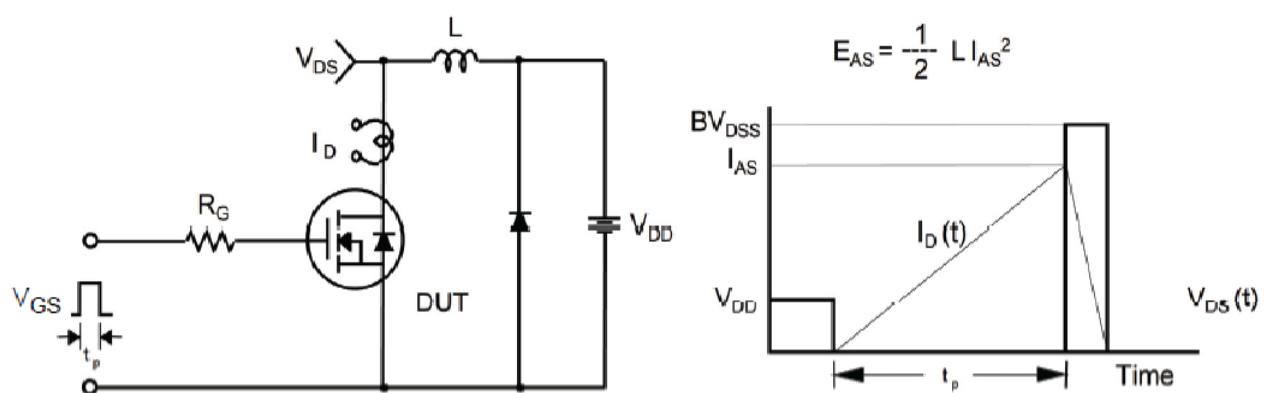
Gate Charge Test Circuit & Waveform

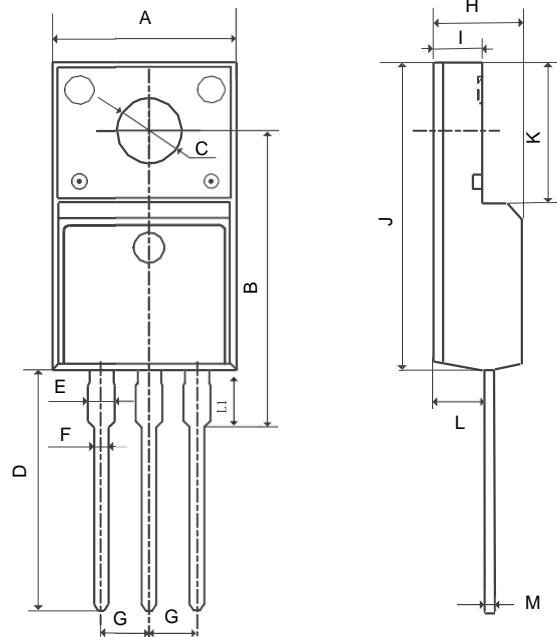


Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms



Mechanical Dimensions for TO-220F**COMMON DIMENSIONS**

SYME	MM		
	MIN	NOM	MAX
A	9.96	10.16	10.36
B	15.10	15.60	16.10
C	3.03	3.20	3.38
D	12.64	12.96	13.28
E	1.18	1.38	1.58
F	0.70	0.81	0.95
G	2.54REF		
H	4.50	4.70	4.90
I	2.34	2.54	2.74
J	15.57	15.87	16.17
K	6.70REF		
L	2.56	2.76	2.96
M	0.40	0.52	0.65
L1	2.85	3.10	3.45